## Notice of References Cited Application/Control No. 10/720,142 Examiner Jefferson A. Evans Applicant(s)/Patent Under Reexamination MIYANO ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,163,434	12-2000	Zhang, Lei	360/294.5
	В	US-6,555,201	04-2003	Dhuler et al.	428/137
	С	US-6,937,131	08-2005	Rodgers et al.	337/144
	D	US-2001/0017750	08-2001	Bonin, Wayne Allen	360/294.6
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ρ					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	v						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.